

<b>Notice of References Cited</b>	Application/Control No. 10/510,452		Applicant(s)/Patent Under Reexamination ERIKSSON ET AL.	
	Examiner Hanh Nguyen		Art Unit 2416	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0237976 A1	10-2005	Waldeen et al.	370/331
*	B	US-2005/0096063 A1	05-2005	Muniere, Vincent	455/452.2
*	C	US-7,447,181	11-2008	Forsell, Mika	370/336
*	D	US-2005/0007980 A1	01-2005	Landais et al.	370/331
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.